

**PowerMOS transistors
Avalanche energy rated**

PHX2N60E

FEATURES

- Repetitive Avalanche Rated
- Fast switching
- Stable off-state characteristics
- High thermal cycling performance
- Isolated package

SYMBOL



QUICK REFERENCE DATA

| |
|-----------------------------|
| $V_{DSS} = 600\text{ V}$ |
| $I_D = 1.3\text{ A}$ |
| $R_{DS(ON)} \leq 6\ \Omega$ |

GENERAL DESCRIPTION

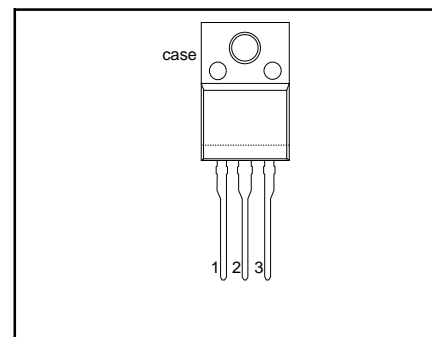
N-channel, enhancement mode field-effect power transistor, intended for use in off-line switched mode power supplies, T.V. and computer monitor power supplies, d.c. to d.c. converters, motor control circuits and general purpose switching applications.

The PHX2N60E is supplied in the SOT186A full pack, isolated package.

PINNING

| PIN | DESCRIPTION |
|------|-------------|
| 1 | gate |
| 2 | drain |
| 3 | source |
| case | isolated |

SOT186A



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|----------------|--|--|------|----------|------------------|
| V_{DSS} | Drain-source voltage | $T_j = 25\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$ | - | 600 | V |
| V_{DGR} | Drain-gate voltage | $T_j = 25\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$; $R_{GS} = 20\text{ k}\Omega$ | - | 600 | V |
| V_{GS} | Gate-source voltage | | - | ± 30 | V |
| I_D | Continuous drain current | $T_{hs} = 25\text{ }^\circ\text{C}$; $V_{GS} = 10\text{ V}$ | - | 1.3 | A |
| | | $T_{hs} = 100\text{ }^\circ\text{C}$; $V_{GS} = 10\text{ V}$ | - | 0.83 | A |
| I_{DM} | Pulsed drain current | $T_{hs} = 25\text{ }^\circ\text{C}$ | - | 7.6 | A |
| P_D | Total dissipation | $T_{hs} = 25\text{ }^\circ\text{C}$ | - | 25 | W |
| T_j, T_{stg} | Operating junction and storage temperature range | | -55 | 150 | $^\circ\text{C}$ |

AVALANCHE ENERGY LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|---|--|------|------|------|
| E_{AS} | Non-repetitive avalanche energy | Unclamped inductive load, $I_{AS} = 1.3\text{ A}$; $t_p = 0.2\text{ ms}$; T_j prior to avalanche = $25\text{ }^\circ\text{C}$; $V_{DD} \leq 50\text{ V}$; $R_{GS} = 50\ \Omega$; $V_{GS} = 10\text{ V}$; refer to fig:17 | - | 102 | mJ |
| E_{AR} | Repetitive avalanche energy ¹ | $I_{AR} = 1.9\text{ A}$; $t_p = 2.5\ \mu\text{s}$; T_j prior to avalanche = $25\text{ }^\circ\text{C}$; $R_{GS} = 50\ \Omega$; $V_{GS} = 10\text{ V}$; refer to fig:18 | - | 3.7 | mJ |
| I_{AS}, I_{AR} | Repetitive and non-repetitive avalanche current | | - | 1.9 | A |

¹ pulse width and repetition rate limited by T_j max.

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ISOLATION LIMITING VALUE & CHARACTERISTIC

 $T_{hs} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------|--|--|------|------|------|------|
| V_{isol} | R.M.S. isolation voltage from all three terminals to external heatsink | $f = 50\text{-}60\text{ Hz}$; sinusoidal waveform; $R.H. \leq 65\%$; clean and dustfree | - | | 2500 | V |
| C_{isol} | Capacitance from T2 to external heatsink | $f = 1\text{ MHz}$ | - | 10 | - | pF |

THERMAL RESISTANCES

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------------------|---|------------------------|------|------|------|------|
| $R_{th\ j\text{-}hs}$ | Thermal resistance junction to heatsink | with heatsink compound | - | - | 5 | K/W |
| $R_{th\ j\text{-}a}$ | Thermal resistance junction to ambient | | - | 55 | - | K/W |

ELECTRICAL CHARACTERISTICS

 $T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|--|---|------|------|------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0\text{ V}$; $I_D = 0.25\text{ mA}$ | 600 | - | - | V |
| $\frac{\Delta V_{(BR)DSS}}{\Delta T_j}$ | Drain-source breakdown voltage temperature coefficient | $V_{DS} = V_{GS}$; $I_D = 0.25\text{ mA}$ | - | 0.1 | - | %/K |
| $R_{DS(ON)}$ | Drain-source on resistance | $V_{GS} = 10\text{ V}$; $I_D = 1\text{ A}$ | - | 4.6 | 6 | Ω |
| $V_{GS(TO)}$ | Gate threshold voltage | $V_{DS} = V_{GS}$; $I_D = 0.25\text{ mA}$ | 2.0 | 3.0 | 4.0 | V |
| g_{fs} | Forward transconductance | $V_{DS} = 30\text{ V}$; $I_D = 1\text{ A}$ | 0.5 | 1.4 | - | S |
| I_{DSS} | Drain-source leakage current | $V_{DS} = 600\text{ V}$; $V_{GS} = 0\text{ V}$ | - | 1 | 100 | μA |
| I_{GSS} | Gate-source leakage current | $V_{DS} = 480\text{ V}$; $V_{GS} = 0\text{ V}$; $T_j = 125\text{ }^{\circ}\text{C}$ $V_{GS} = \pm 30\text{ V}$; $V_{DS} = 0\text{ V}$ | - | 50 | 500 | μA |
| $Q_{g(tot)}$ | Total gate charge | $I_D = 2\text{ A}$; $V_{DD} = 480\text{ V}$; $V_{GS} = 10\text{ V}$ | - | 20 | 25 | nC |
| Q_{gs} | Gate-source charge | | - | 2 | 3 | nC |
| Q_{gd} | Gate-drain (Miller) charge | | - | 9 | 15 | nC |
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 300\text{ V}$; $R_D = 150\text{ }\Omega$; | - | 10 | - | ns |
| t_r | Turn-on rise time | $R_G = 24\text{ }\Omega$ | - | 20 | - | ns |
| $t_{d(off)}$ | Turn-off delay time | | - | 60 | - | ns |
| t_f | Turn-off fall time | | - | 20 | - | ns |
| L_d | Internal drain inductance | Measured from drain lead to centre of die | - | 4.5 | - | nH |
| L_s | Internal source inductance | Measured from source lead to source bond pad | - | 7.5 | - | nH |
| C_{iss} | Input capacitance | $V_{GS} = 0\text{ V}$; $V_{DS} = 25\text{ V}$; $f = 1\text{ MHz}$ | - | 236 | - | pF |
| C_{oss} | Output capacitance | | - | 34 | - | pF |
| C_{rss} | Feedback capacitance | | - | 20 | - | pF |

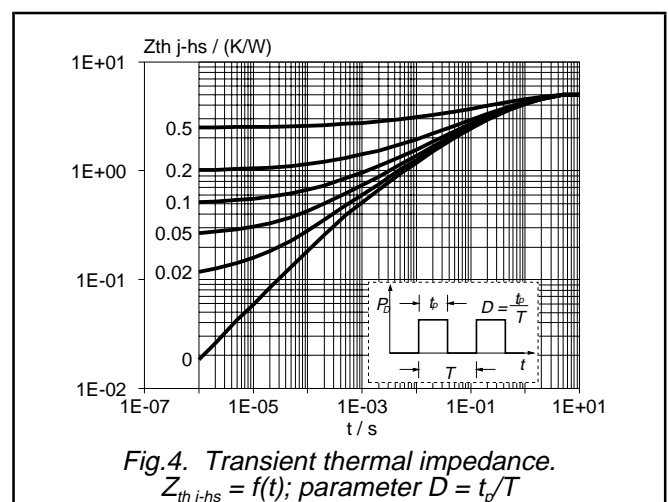
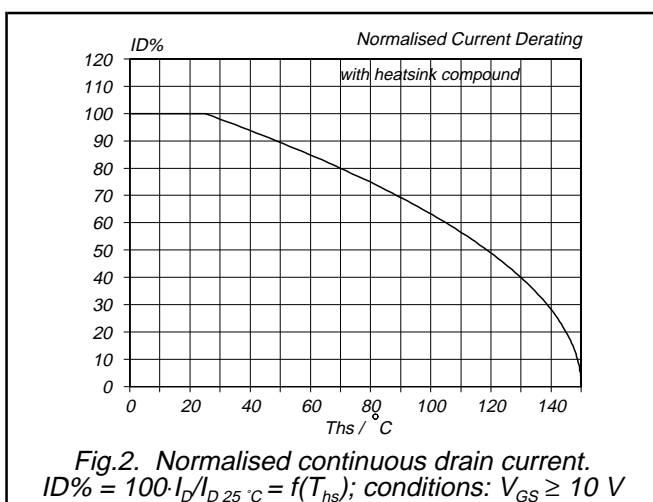
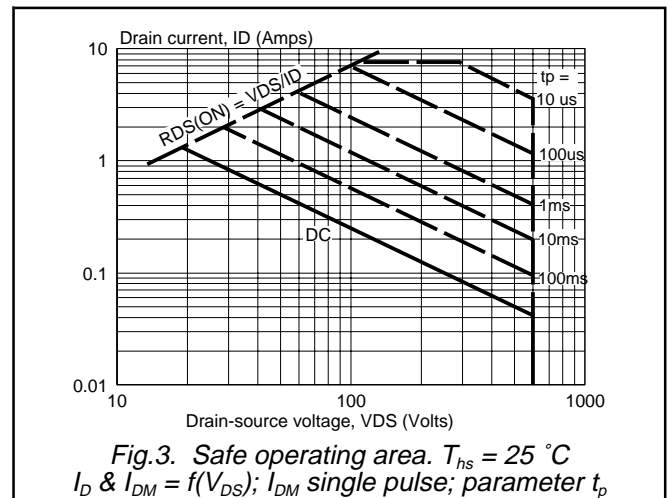
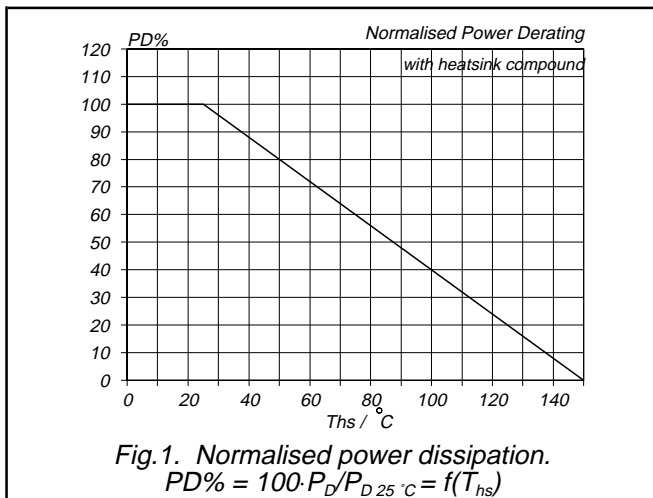
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SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

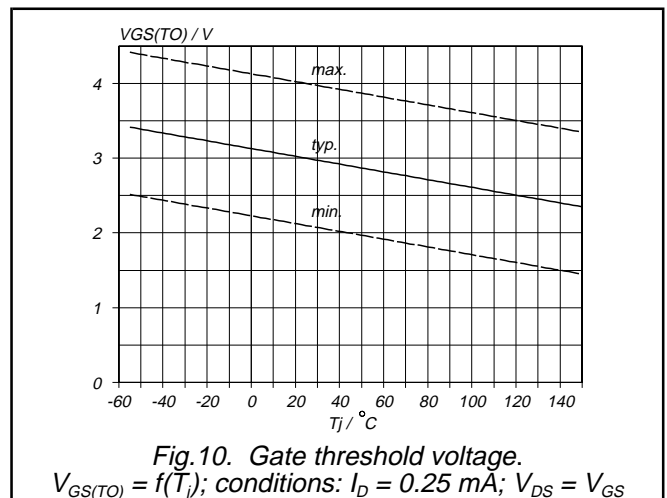
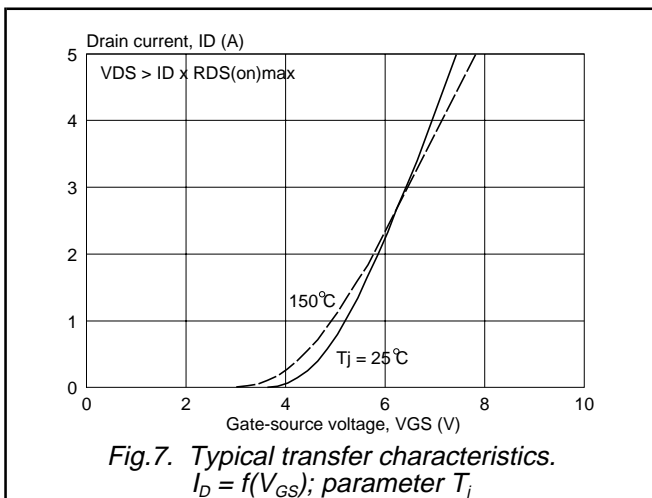
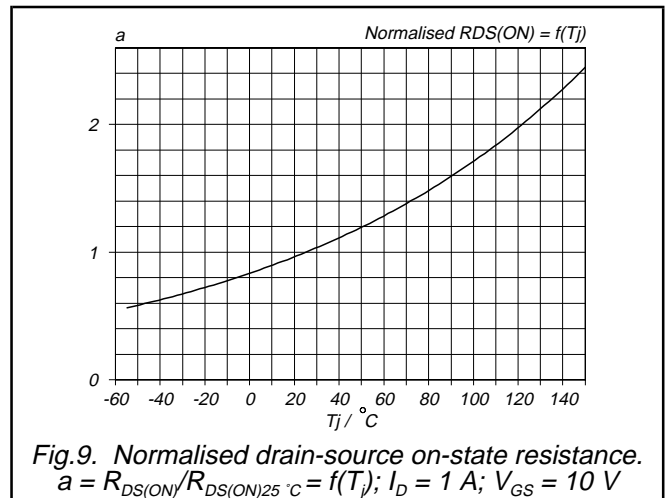
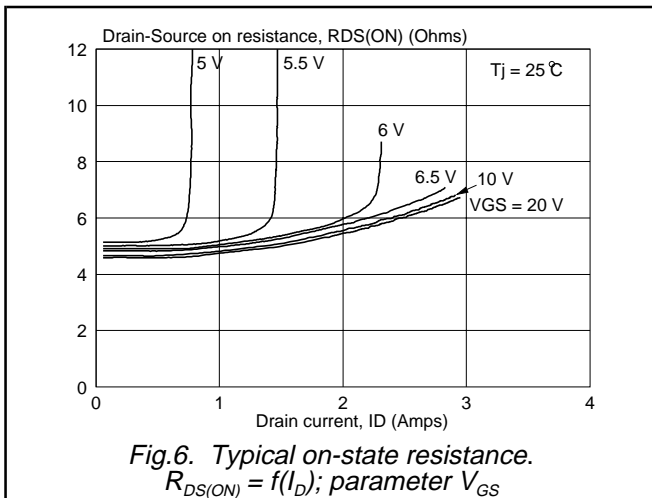
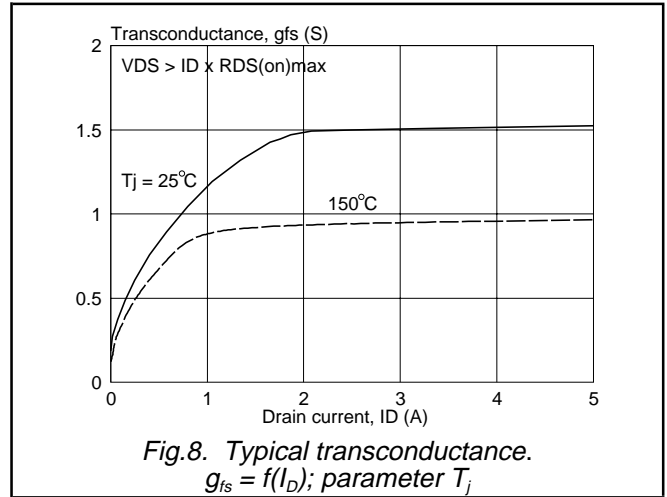
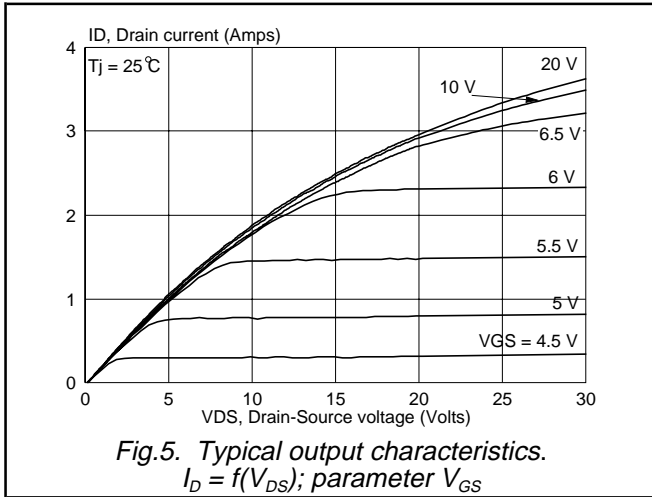
$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|----------|--|---|------|------|------|---------------|
| I_S | Continuous source current (body diode) | $T_{hs} = 25\text{ }^\circ\text{C}$ | - | - | 1.9 | A |
| I_{SM} | Pulsed source current (body diode) | $T_{hs} = 25\text{ }^\circ\text{C}$ | - | - | 7.6 | A |
| V_{SD} | Diode forward voltage | $I_S = 2\text{ A}; V_{GS} = 0\text{ V}$ | - | - | 1.2 | V |
| t_{rr} | Reverse recovery time | $I_S = 2\text{ A}; V_{GS} = 0\text{ V}; di/dt = 100\text{ A}/\mu\text{s}$ | - | 360 | - | ns |
| Q_{rr} | Reverse recovery charge | | - | 2.4 | - | μC |



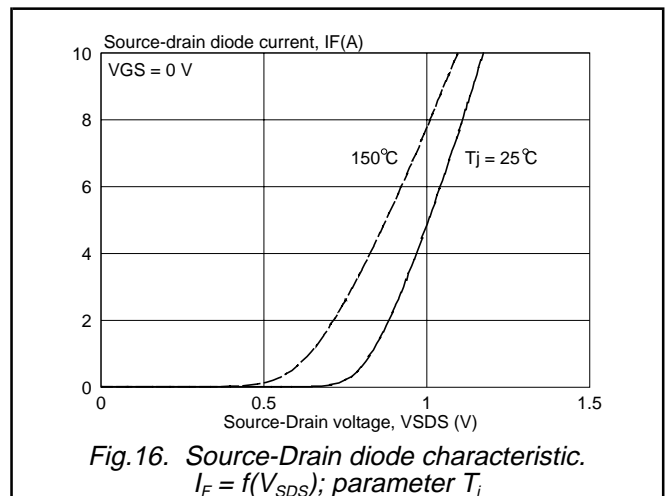
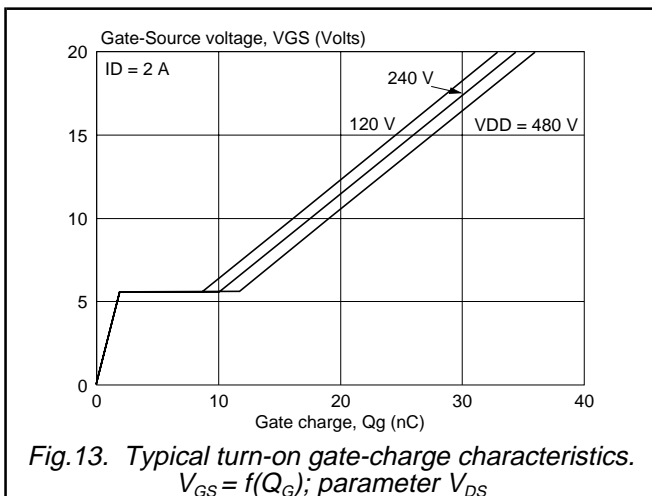
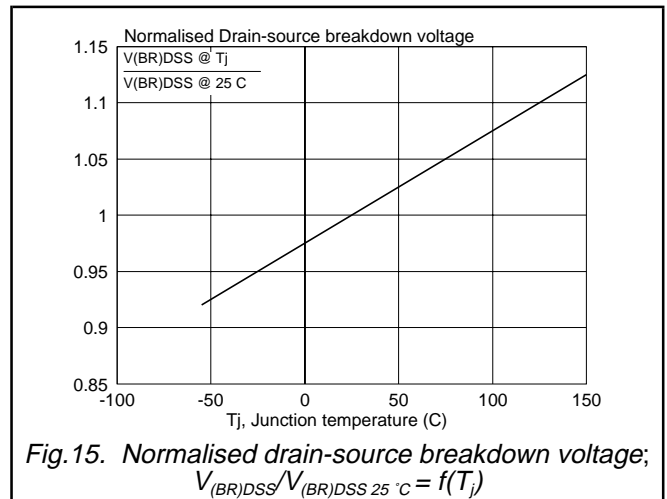
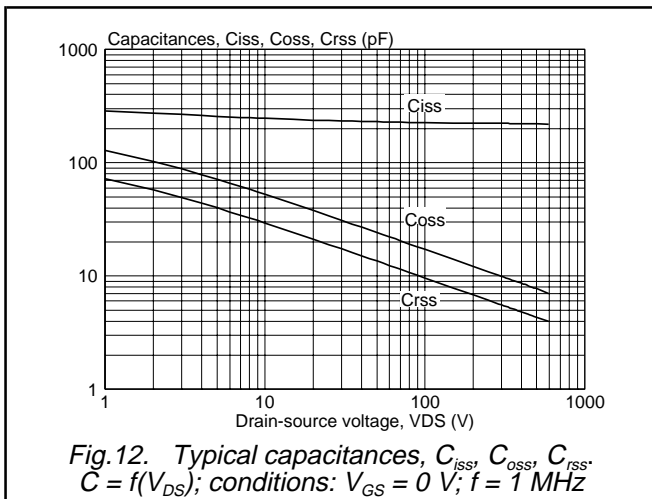
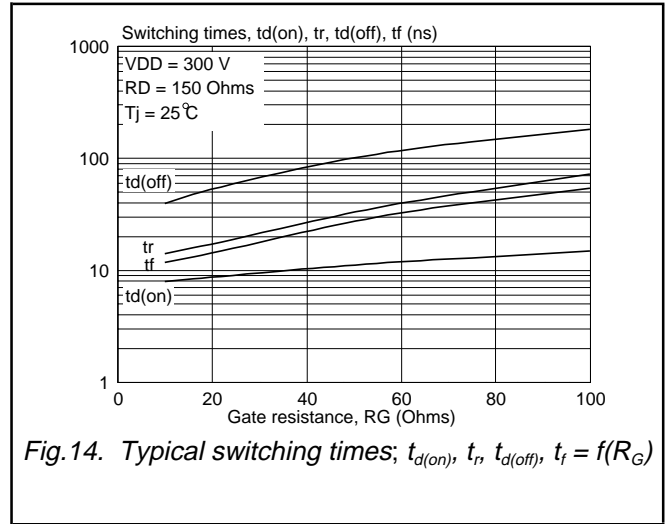
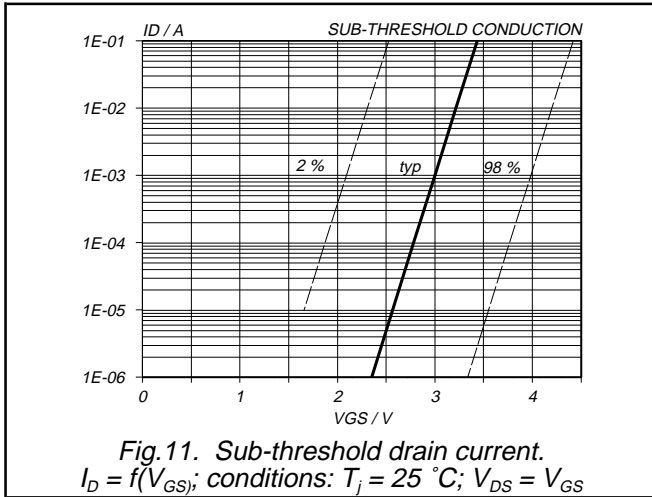
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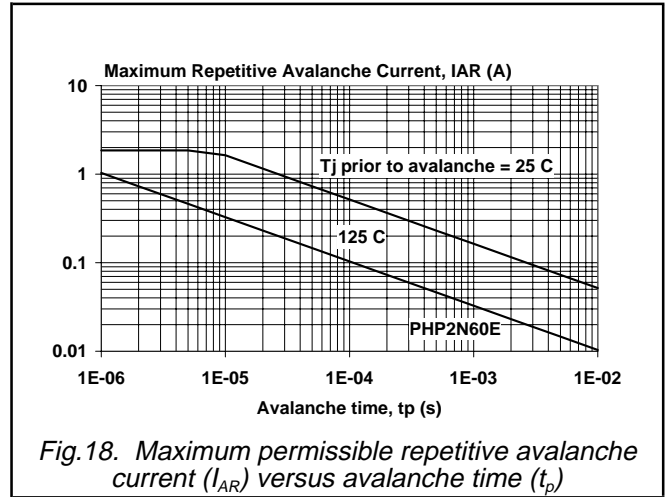
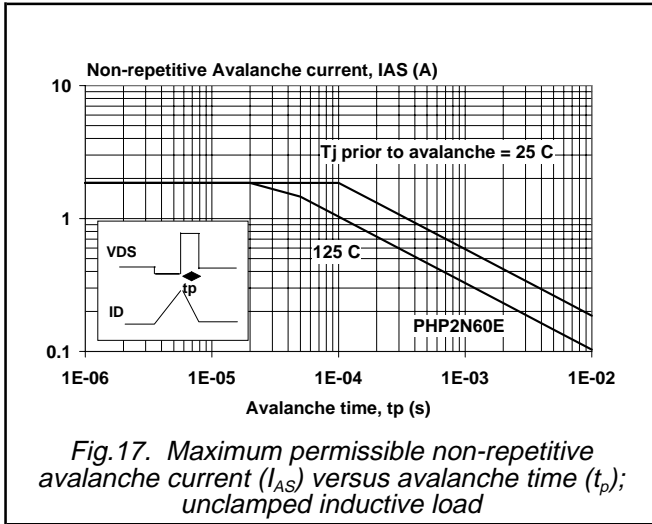
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MECHANICAL DATA

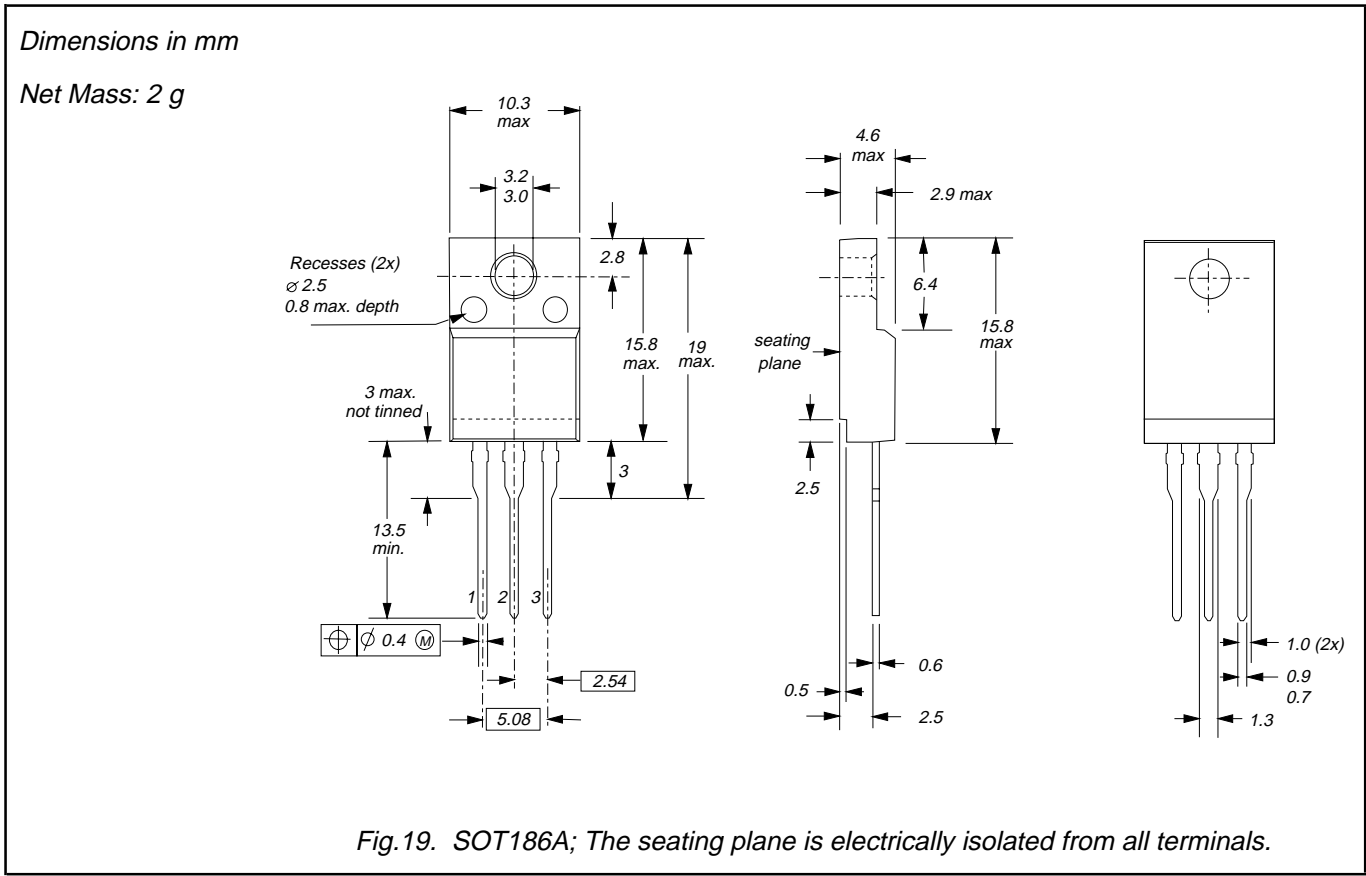


Fig. 19. SOT186A; The seating plane is electrically isolated from all terminals.

Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for F-pack envelopes.
3. Epoxy meets UL94 V0 at 1/8".

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DEFINITIONS

| | |
|--|---|
| Data sheet status | |
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | |
| Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | |
| Application information | |
| Where application information is given, it is advisory and does not form part of the specification. | |
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